

| | | | | |
|-----------------------------------|---------------------------------------|--|--|-------------|
| Notice of References Cited | Application/Control No. 10/696,435 | | Applicant(s)/Patent Under Reexamination NAKAMURA ET AL. | |
| | Examiner Tho D. Ta | | Art Unit 2833 | Page 1 of 1 |

U.S. PATENT DOCUMENTS

| * | | Document Number Country Code-Number-Kind Code | Date MM-YYYY | Name | Classification |
|---|---|--|-----------------|-----------------|----------------|
| * | A | US-5,468,162 A | 11-1995 | Oda, Kenzo | 439/752 |
| * | B | US-5,573,432 A | 11-1996 | Hatagishi, Yuji | 439/752 |
| * | C | US-5,997,365 A | 12-1999 | Abe, Kimihiro | 439/752 |
| * | D | US-6,592,411 B2 | 07-2003 | Mase et al. | 439/752 |
| * | E | US-6,645,015 B2 | 11-2003 | Mase et al. | 439/752 |
| * | F | US-6,659,798 B2 | 12-2003 | Mase et al. | 439/595 |
| * | G | US-6,695,651 B2 | 02-2004 | Mase et al. | 439/752 |
| | H | US- | | | |
| | I | US- | | | |
| | J | US- | | | |
| | K | US- | | | |
| | L | US- | | | |
| | M | US- | | | |

FOREIGN PATENT DOCUMENTS

| * | | Document Number Country Code-Number-Kind Code | Date MM-YYYY | Country | Name | Classification |
|---|---|--|-----------------|---------|------|----------------|
| | N | | | | | |
| | O | | | | | |
| | P | | | | | |
| | Q | | | | | |
| | R | | | | | |
| | S | | | | | |
| | T | | | | | |

NON-PATENT DOCUMENTS

| * | | Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages) |
|---|---|---|
| | U | |
| | V | |
| | W | |
| | X | |

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.